Search Notes



App	lica	tion	Contr	ol No
-----	------	------	-------	-------

10539366

Applicant(s)/Patent Under Reexamination

TIEKE ET AL.

Examiner

Art Unit

ANEETA PATANKAR

4134

SEARCHED

Class	Subclass	Date	Examiner
369	59.11, 59.12	4/2/2008	AVP

SEARCH	NOIES	

Search Notes	Date	Examiner
East	4/2/2008	AVP
Inventor Search	4/3/2008	AVP
Consulted with Joseph Haley	4/2/2008	AVP
Consulted with Wayne Young	4/2/2008	AVP
EAST	10/23/08	A.P.

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner

/A. P./ Examiner.Art Unit 2627	

U.S. Patent and Trademark Office Part of Paper No.: 20081023